Application/Control No. Applicant(s)/Patent Under Reexamination 10/626,096 LEE ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2818 **DAVID VU U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY 438/257 Chang et al. 01-2001 US-6,180,454 Oka et al. 05-2001 438/166 US-6,235,563 Prinz et al. 438/257 US-6,133,093 10-2000 C US-D US-Ε US-US-G US-Н US-US-US-US-US-M FOREIGN PATENT DOCUMENTS **Document Number** Date Classification Name Country * MM-YYYY Country Code-Number-Kind Code Ν 0 Q R S T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

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